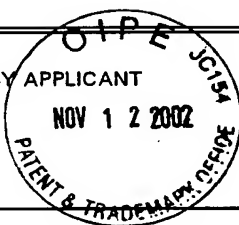


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## LIST OF REFERENCES CITED BY APPLICANT

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10/067,762APPLICANT  
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February 6, 2002GROUP  
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## U. S. PATENT DOCUMENT

EXAMINER INITIALS		PATENT NO.	ISSUE DATE	PATENTEE	CLASS	SUBCLASS	FILING DATE
TMD	AA	3,731,214	5/1/1973	Bers	330	5.5	
TMD	AB	3,649,857	3/14/1972	Knappe	310	328	
TMD	AC	3,558,936	1/26/1971	Horan	310	328	
TMD	AD	3,548,314	12/15/1970	Mitchell	310	317	
TMD	AE	3,513,309	5/19/1970	Hehemann	250	74	
TMD	AF	3,446,920	5/27/1969	Zuerkr	310	317	
TMD	AG	3,421,109	1/7/1969	Wiggins et al.	331	1881	
TMD	AH	3,414,779	12/3/1968	Bohm	317	234	
TMD	AI	Re. 34,823	1/10/1995	Sakaida et al.	310	328	
TMD	AJ	3,405,289	10/8/1968	Gikow	310	328	

## FOREIGN PATENT OR PUBLISHED PATENT APPLICATION

		DOCUMENT NO.	PUBLICATION DATE	COUNTRY OR PATENT OFFICE	CLASS	SUBCLASS	TRANSLATION
TMD	AL	JP6105568	1994-04-15	Japan	H02N	2/00	abstract
TMD	AM	JP62217880	1987-09-25	Japan	H02N	2/00	abstract
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## OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)

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LIST OF REFERENCES CITED BY APPLICANT

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U. S. PATENT DOCUMENT

EXAMINER INITIALS		PATENT NO.	ISSUE DATE	PATENTEE	CLASS	SUBCLASS	FILING DATE
TMD	AA	6,411,009	6/25/2002	Jaenker	310	328	
TMD	AB	6,294,859	9/25/2001	Jaenker	310	328	
TMD	AC	6,291,928	9/18/2001	Lazarus et al.	310	328	
TMD	AD	6,246,287	6/12/2001	Yamashita	330	174	
TMD	AE	6,131,879	10/17/2000	Kluge et al.	251	129.06	
TMD	AF	6,003,836	12/21/1999	Cewers	251	129.06	
TMD	AG	5,907,211	5/25/1999	Hall et al.	310	328	
TMD	AH	5,859,561	1/12/1999	Vanoli	327	516	
TMD	AI	5,779,149	7/14/1998	Hayes Jr.	239	124	
TMD	AJ	5,501,986	3/26/1996	Ward et al.	436	525	
TMD	AK	5,479,064	12/26/1995	Sano	310	328	

FOREIGN PATENT OR PUBLISHED PATENT APPLICATION

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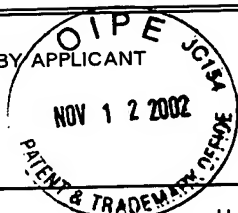
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FORM PTO-1448 LIST OF REFERENCES CITED BY APPLICANT				ATTY. DOCKET NO. VTE-120-A		SERIAL NO. 10/067,762	
				APPLICANT Jeff Moler		GROUP 2834	
				FILING DATE February 6, 2002			
U. S. PATENT DOCUMENT							
EXAMINER INITIALS		PATENT NO.	ISSUE DATE	PATENTEE	CLASS	SUBCLASS	FILING DATE
TMB	AA	5,444,324	8/22/1995	Priest et al.	310	328	RECEIVED NOV 19 2002
TMD	AB	5,410,207	4/25/1995	Miura et al.	310	328	
TMD	AC	5,270,984	12/14/1993	Mine	367	147	
TMD	AD	5,239,904	8/31/1993	Yamaguchi et al.	83	218	
TMD	AE	5,205,147	4/27/1993	Wada et al.	72	429	
TMD	AF	5,191,252	3/2/1993	Sano	310	328	
TMD	AG	5,115,880	5/26/1992	Sallas et al.	181	166	
TMD	AH	5,078,241	1/7/1992	Ackermann et al.	188	299	
TMD	AI	5,063,542	11/5/1991	Petermann et al.	367	166	
TMD	AJ	5,028,834	7/2/1991	Sakaida et al.	310	328	
TMD	AK	5,004,946	4/2/1991	Sakaida et al.	310	328	
TMD	AL	4,999,284	3/12/1991	Ward et al.	435	4	
FOREIGN PATENT OR PUBLISHED PATENT APPLICATION							
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## U. S. PATENT DOCUMENT

EXAMINER INITIALS		PATENT NO.	ISSUE DATE	PATENTEE	CLASS	SUBCLASS	FILING DATE
TMD	AA	4,979,275	12/25/1990	Sakaida et al.	29	25.35	
TMD	AB	4,937,489	6/26/1990	Hattori et al.	310	328	
TMD	AC	4,933,591	6/12/1990	Stahlhuth	310	328	
TMD	AD	4,929,859	5/29/1990	Suzuki et al.	310	328	
TMD	AE	4,874,980	10/17/1989	Mine et al.	310	328	
TMD	AF	4,874,978	10/17/1989	Sakaida et al.	310	328	
TMD	AG	4,847,193	7/11/1989	Richards et al.	435	6	
TMD	AH	4,835,747	5/30/1989	Billet	367	164	
TMD	AI	4,816,713	3/28/1989	Change, Jr.	310	319	
TMD	AJ	4,808,874	2/28/1989	Stahlhuth	310	328	
TMD	AK	4,783,610	11/8/1988	Asano	310	328	

## FOREIGN PATENT OR PUBLISHED PATENT APPLICATION

	DOCUMENT NO.	PUBLICATION DATE	COUNTRY OR PATENT OFFICE	CLASS	SUBCLASS	TRANSLATION
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## OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)

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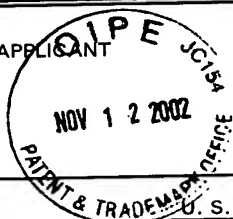
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## U. S. PATENT DOCUMENT

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TMD	AA	4,769,569	9/6/1988	Stahlhuth	310	328	
TMD	AB	4,703,215	10/27/1987	Asano	310	328	
TMD	AC	4,675,568	6/23/1987	Uchikawa et al.	310	328	
TMD	AD	4,647,808	3/3/1987	Shibuya	310	328	
TMD	AE	4,629,039	12/16/1986	Imoto et al.	188	72.1	
TMD	AF	4,570,095	2/11/1986	Uchikawa	310	328	
TMD	AG	4,460,840	7/17/1984	Weiger et al.	310	328	
TMD	AH	4,435,666	3/6/1984	Fukui et al.	310	328	
TMD	AI	4,318,023	3/2/1982	O'Neill et al.	310	328	
TMD	AJ	4,287,582	9/1/1981	Tocquet	367	16.8	
TMD	AK	4,214,215	7/22/1980	Mellen et al.	330	27	
TMD	AL	4,193,703	3/18/1980	Kakmann	400	12	
TMD	AM	4,009,447	2/22/1977	Wolf et al.	310	320	
TMD	AN	3,749,946	7/31/1973	Von Ruti	310	379	

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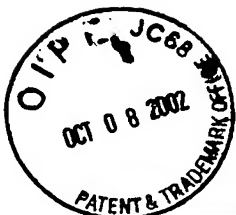
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## U. S. PATENT DOCUMENT

EXAMINER INITIALS		PATENT NO.	ISSUE DATE	PATENTEE	CLASS	SUBCLASS	FILING DATE
TMY	AA	6,003,836	12-21-1999	Cewers	251	129.06	
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## FOREIGN PATENT OR PUBLISHED PATENT APPLICATION

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TMD	AL	JP3234981	10-18-1991	Japan	F16K	31/02	abstract
TMD	AM	DE4220177	07-12-1994	Germany	H01L	41/09	abstract
TMD	AN	JP8093944	04-12-1996	Japan	F16K	31/02	abstract
TMD	AO	DE19946003	05-25-2000	Germany	H01L	41/09	abstract
TMD	AP	DE19946838	10-19-2000	Germany	H01L	41/083	abstract

## OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)

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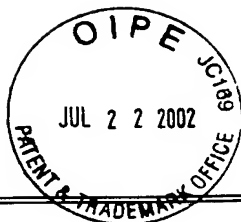
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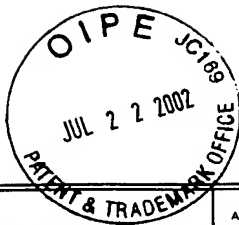
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				APPLICANT Jeff Moler			
				FILING DATE February 6, 2002		GROUP 2834	
U. S. PATENT DOCUMENT							
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TMD	AA	6,246,157	Oliver et al.	310	328	08-23-1999	
TMD	AB	5,824,937	Szalay	84	654	04-11-1996	
TMD	AC	5,500,777	Hasegawa et al.	360	77.16	05-18-1994	
TMD	AD	5,072,288	MacDonald et al.	357	68	02-21-1989	
TMD	AE	4,857,791	Uchino et al.	310	321	06-03-1988	
TMD	AF	4,612,440	Brunnee et al.	250	281	09-10-1984	
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TMD	AL	7-236287	Japan	H02N	2/00	no	
TMD	AM	62-23381	Japan	310	311	abstract	
TMD	AN	62-217880	Japan	H02N	2/00	abstract	
TMD	AO	61-150287	Japan	H01L	41/08	abstract	
TMD	AP	6-105568	Japan	310	331	abstract	
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)							
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U. S. PATENT DOCUMENT

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TMD	AL	4-165966	11-1992	Japan	H02N	2/00	NO
TMD	AM	2-260476	10-1990	Japan	310	328	abstract
TMD	AN	1-152976	06-1989	Japan	H01L	41/09	abstract
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